

REVISIONS

LTR	DESCRIPTION	DATE (YR-MO-DA)	APPROVED
A	Drawing updated to reflect current requirements. – gt	04-04-29	R. Monnin
B	Added footnote 1 to table II, under group C end-point electricals. Updated drawing paragraphs. -sld	11-05-20	Charles F. Saffle

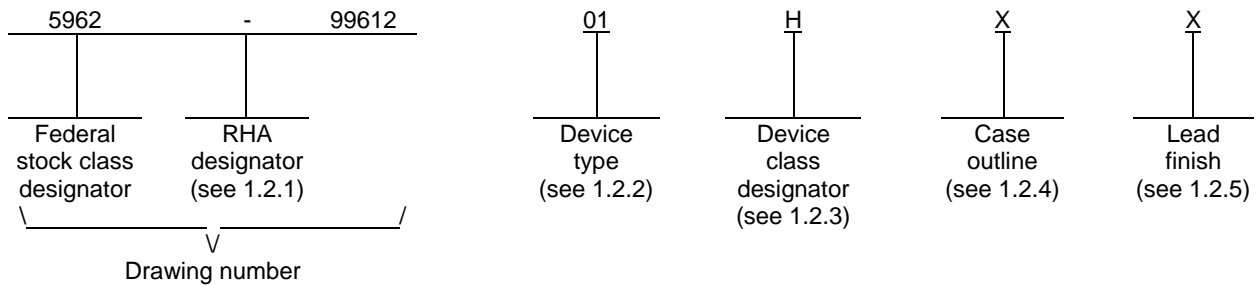
REV																				
SHEET																				
REV																				
SHEET																				
REV STATUS OF SHEETS	REV	B	B	B	B	B	B	B	B	B	B	B	B	B	B	B	B			
	SHEET	1	2	3	4	5	6	7	8	9	10	11	12	13						

PMIC N/A	PREPARED BY Gary Zahn	<p align="center">DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990 http://www.dsccl.dla.mil</p>																	
<p align="center">STANDARD MICROCIRCUIT DRAWING</p> <p align="center">THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS AND AGENCIES OF THE DEPARTMENT OF DEFENSE</p> <p align="center">AMSC N/A</p>	CHECKED BY Michael C. Jones																		
	APPROVED BY Ray Monnin	<p align="center">MICROCIRCUIT, LINEAR, ADJUSTABLE VOLTAGE REGULATOR, MONOLITHIC SILICON</p>																	
	DRAWING APPROVAL DATE 99-08-09																		
	REVISION LEVEL B	<table border="1"> <tr> <td>SIZE A</td> <td>CAGE CODE 67268</td> <td>5962-99612</td> </tr> </table>	SIZE A	CAGE CODE 67268	5962-99612														
SIZE A	CAGE CODE 67268	5962-99612																	
		SHEET 1 OF 13																	

1. SCOPE

1.1 Scope. This drawing documents five product assurance classes as defined in paragraph 1.2.3 and MIL-PRF-38534. A choice of case outlines and lead finishes which are available and are reflected in the Part or Identifying Number (PIN). When available, a choice of radiation hardness assurance levels are reflected in the PIN.

1.2 PIN. The PIN shall be as shown in the following example:



1.2.1 Radiation hardness assurance (RHA) designator. RHA marked devices shall meet the MIL-PRF-38534 specified RHA levels and shall be marked with the appropriate RHA designator. A dash (-) indicates a non-RHA device.

1.2.2 Device type(s). The device type(s) identify the circuit function as follows:

<u>Device type</u>	<u>Generic number</u>	<u>1/</u>	<u>Circuit function</u>
01	SDP117		Positive adjustable voltage regulator
02	SDP117HV		Positive adjustable voltage regulator, high voltage
03	SDP137		Negative adjustable voltage regulator
04	SDP137HV		Negative adjustable voltage regulator, high voltage

1.2.3 Device class designator. This device class designator shall be a single letter identifying the product assurance level. All levels are defined by the requirements of MIL-PRF-38534 and require QML Certification as well as qualification (Class H, K, and E) or QML Listing (Class G and D). The product assurance levels are as follows:

<u>Device class</u>	<u>Device performance documentation</u>
K	Highest reliability class available. This level is intended for use in space applications.
H	Standard military quality class level. This level is intended for use in applications where non-space high reliability devices are required.
G	Reduced testing version of the standard military quality class. This level uses the Class H screening and In-Process Inspections with a possible limited temperature range, manufacturer specified incoming flow, and the manufacturer guarantees (but may not test) periodic and conformance inspections (Group A, B, C and D).
E	Designates devices which are based upon one of the other classes (K, H, or G) with exception(s) taken to the requirements of that class. These exception(s) must be specified in the device acquisition document; therefore the acquisition document should be reviewed to ensure that the exception(s) taken will not adversely affect system performance.
D	Manufacturer specified quality class. Quality level is defined by the manufacturers internal, QML certified flow. This product may have a limited temperature range.

^{1/} The SDP117, SDP117HV, SDP137, and SDP137HV are similar to the LM117, LM117HV, LM137, and LM137HV listed on Standard Microcircuit Drawing 77034.

STANDARD MICROCIRCUIT DRAWING DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE A		5962-99612
		REVISION LEVEL B	SHEET 2

1.2.4 Case outline(s). The case outline(s) are as designated in MIL-STD-1835 and as follows:

<u>Outline letter</u>	<u>Descriptive designator</u>	<u>Terminals</u>	<u>Package style</u>
N	See figure 1	3	Z-tab with nonisolated tab, (TO-257Z), with glass seal
T	See figure 1	3	Flange mount with nonisolated tab, (TO-257), with glass seal
U	See figure 1	3	Flange mount with isolated tab, (TO-257), with glass seal
Z	See figure 1	3	Z-tab with isolated tab, (TO-257Z), with glass seal

1.2.5 Lead finish. The lead finish shall be as specified in MIL-PRF-38534.

1.3 Absolute maximum ratings. ^{1/}

Input-output voltage differential:

Device types 01 and 03.....	40 V dc
Device type 02.....	60 V dc
Device type 04.....	50 V dc

Operating junction temperature range-55°C to +150°C

Storage temperature-65°C to +150°C

Lead temperature (soldering, 10 seconds).....300°C

Power dissipation (P_D)20 W

Thermal resistance, junction to case (θ_{JC}):

Cases N and T3.5°C/W

Cases U and Z4.2°C/W

Maximum output current (I_{MAX}).....1.5 A

1.4 Recommended operating conditions.

Output voltage range:

Device type 01	1.2 to 37 V dc
Device type 02	1.2 to 57 V dc
Device type 03	-1.2 to -37 V dc
Device type 04	-1.2 to -47 V dc

Input voltage range:

Device type 01	4.25 V dc to 41.25 V dc
Device type 03	-4.25 V dc to -41.25 V dc
Device type 02	4.25 V dc to 61.25 V dc
Device type 04	-4.25 V dc to -51.25 V dc

Ambient operating temperature range (T_A)-55°C to +125°C

2. APPLICABLE DOCUMENTS

2.1 Government specification, standards, and handbooks. The following specification, standards, and handbooks form a part of this drawing to the extent specified herein. Unless otherwise specified, the issues of these documents are those cited in the solicitation or contract.

^{1/} Stresses above the absolute maximum rating may cause permanent damage to the device. Extended operation at the maximum levels may degrade performance and affect reliability.

STANDARD MICROCIRCUIT DRAWING DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE A		5962-99612
		REVISION LEVEL B	SHEET 3

DEPARTMENT OF DEFENSE SPECIFICATIONS

MIL-PRF-38534 - Hybrid Microcircuits, General Specification for.

DEPARTMENT OF DEFENSE STANDARDS

MIL-STD-883 - Test Method Standard Microcircuits.
MIL-STD-1835 - Interface Standard for Electronic Component Case Outlines.

DEPARTMENT OF DEFENSE HANDBOOKS

MIL-HDBK-103 - List of Standard Microcircuit Drawings.
MIL-HDBK-780 - Standard Microcircuit Drawings.

(Copies of these documents are available online at <https://assist.daps.dla.mil/quicksearch/> or from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

3. REQUIREMENTS

3.1 Item requirements. The individual item performance requirements for device classes D, E, G, H, and K shall be in accordance with MIL-PRF-38534. Compliance with MIL-PRF-38534 shall include the performance of all tests herein or as designated in the device manufacturer's Quality Management (QM) plan or as designated for the applicable device class. The manufacturer may eliminate, modify or optimize the tests and inspections herein, however the performance requirements as defined in MIL-PRF-38534 shall be met for the applicable device class. In addition, the modification in the QM plan shall not affect the form, fit, or function of the device for the applicable device class.

3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38534 and herein.

3.2.1 Case outline(s). The case outline(s) shall be in accordance with 1.2.4 herein and figure 1.

3.2.2 Terminal connections. The terminal connections shall be as specified on figure 2.

3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full specified operating temperature range.

3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are defined in table I.

3.5 Marking of device(s). Marking of device(s) shall be in accordance with MIL-PRF-38534. The device shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's vendor similar PIN may also be marked.

3.6 Data. In addition to the general performance requirements of MIL-PRF-38534, the manufacturer of the device described herein shall maintain the electrical test data (variables format) from the initial quality conformance inspection group A lot sample, for each device type listed herein. Also, the data should include a summary of all parameters manually tested, and for those which, if any, are guaranteed. This data shall be maintained under document revision level control by the manufacturer and be made available to the preparing activity (DLA Land and Maritime -VA) upon request.

STANDARD MICROCIRCUIT DRAWING DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE A		5962-99612
		REVISION LEVEL B	SHEET 4

3.7 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to supply to this drawing. The certificate of compliance (original copy) submitted to DLA Land and Maritime -VA shall affirm that the manufacturer's product meets the performance requirements of MIL-PRF-38534 and herein.

3.8 Certificate of conformance. A certificate of conformance as required in MIL-PRF-38534 shall be provided with each lot of microcircuits delivered to this drawing.

4. VERIFICATION

4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with MIL-PRF-38534 or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein.

4.2 Screening. Screening shall be in accordance with MIL-PRF-38534. The following additional criteria shall apply:

- a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to either DLA Land and Maritime -VA or the acquiring activity upon request. Also, the test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1015 of MIL-STD-883.
 - (2) T_A as specified in accordance with table I of method 1015 of MIL-STD-883.
- b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 Conformance and periodic inspections. Conformance inspection (CI) and periodic inspection (PI) shall be in accordance with MIL-PRF-38534 and as specified herein.

4.3.1 Group A inspection (CI). Group A inspection shall be in accordance with MIL-PRF-38534 and as follows:

- a. Tests shall be as specified in table II herein.
- b. Subgroups 7, 8, 9, 10, and 11 shall be omitted.

4.3.2 Group B inspection (PI). Group B inspection shall be in accordance with MIL-PRF-38534.

4.3.3 Group C inspection (PI). Group C inspection shall be in accordance with MIL-PRF-38534 and as follows:

- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test, method 1005 of MIL-STD-883.
 - (1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to either DLA Land and Maritime -VA or the acquiring activity upon request. Also, the test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1005 of MIL-STD-883.
 - (2) T_A as specified in accordance with table I of method 1005 of MIL-STD-883.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

4.3.4 Group D inspection (PI). Group D inspection shall be in accordance with MIL-PRF-38534.

STANDARD MICROCIRCUIT DRAWING DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE A		5962-99612
		REVISION LEVEL B	SHEET 5

TABLE I. Electrical performance characteristics.

Test	Symbol	Conditions -55°C ≤ T _A ≤ +125°C I _L = 8 mA unless otherwise specified	Group A subgroups	Device type	Limits		Unit
					Min	Max	
Device types 01 and 02.							
Reference voltage	V _{REF}	V _{DIFF} = 3.0 V	1	01,02	1.20	1.30	V
		V _{DIFF} = 3.3 V	2,3		1.20	1.30	
		V _{DIFF} = 40 V	1,2,3		1.20	1.30	
		V _{DIFF} = 60 V	1,2,3	02	1.20	1.30	
Line regulation <u>1/</u>	R _{LINE}	V _{OUT} = V _{REF} , 3.0 V ≤ V _{DIFF} ≤ 40 V	1	01,02		±9	mV
		V _{OUT} = V _{REF} , 3.3 V ≤ V _{DIFF} ≤ 40 V	2,3			±23	
		V _{OUT} = V _{REF} , 40 V ≤ V _{DIFF} ≤ 60 V	1	02		±5	
			2,3			±10	
Load regulation <u>2/</u>	R _{LOAD}	V _{DIFF} = 3 V, 10 mA ≤ I _L ≤ 1.5 A	1	01,02		±15	mV
		V _{DIFF} = 3.3 V, 10 mA ≤ I _L ≤ 1.5 A	2,3			±15	
		V _{DIFF} = 40V, 10 mA ≤ I _L ≤ 300 mA	1			±15	
		V _{DIFF} = 40 V, 10 mA ≤ I _L ≤ 195 mA	2,3			±15	
		V _{DIFF} = 60 V, 10 mA ≤ I _L ≤ 30 mA	1,2,3	02		±15	
Thermal regulation	V _{RTH}	V _{IN} = 14.6 V, I _L = 1.5 A, P _D = 20 watts, t = 20 ms, T _A = +25°C	1	01,02		±16	mV
Ripple rejection <u>3/</u>	R _N	f = 120 Hz, C _{ADJ} = 10 μF, V _{OUT} = V _{REF}	4,5,6	01	66		dB
		f = 120 Hz, C _{ADJ} = 10 μF, V _{OUT} = V _{REF} , I _{OUT} = 100 mA		02	66		
Adjustment pin current	I _{ADJ}	V _{DIFF} = 3.0 V	1	01,02		100	μA
		V _{DIFF} = 3.3 V	2,3			100	
		V _{DIFF} = 40 V	1,2,3			100	
		V _{DIFF} = 60 V	1,2,3	02		100	

See footnotes at end of table.

**STANDARD
MICROCIRCUIT DRAWING**
DLA LAND AND MARITIME
COLUMBUS, OHIO 43218-3990

SIZE
A

5962-99612

REVISION LEVEL
B

SHEET
6

TABLE I. Electrical performance characteristics – Continued.

Test	Symbol	Conditions -55°C ≤ T _A ≤ +125°C I _L = 8 mA unless otherwise specified	Group A subgroups	Device type	Limits		Unit
					Min	Max	
Device types 01 and 02 - Continued.							
Adjustment pin current change	ΔI _{ADJ}	V _{DIFF} = 3 V, 10 mA ≤ I _L ≤ 1.5 A	1	01,02		±5	μA
		V _{DIFF} = 3.3 V, 10 mA ≤ I _L ≤ 1.5 A	2,3			±5	
		V _{DIFF} = 40 V, 10 mA ≤ I _L ≤ 300 mA	1			±5	
		V _{DIFF} = 40 V, 10 mA ≤ I _L ≤ 195 mA	2,3			±5	
		3 V ≤ V _{DIFF} ≤ 40 V	1			±5	
		3.3 V ≤ V _{DIFF} ≤ 40 V	2,3			±5	
		3.3 V ≤ V _{DIFF} ≤ 60 V	1,2,3	02	±5		
Minimum load current	I _{LMIN}	V _{DIFF} = 3.0 V, V _{OUT} = 1.4 V (forced)	1	01,02		5	mA
		V _{DIFF} = 3.3 V, V _{OUT} = 1.4 V (forced)	2,3			5	
		V _{DIFF} = 40 V, V _{OUT} = 1.4 V (forced)	1,2,3			5	
		V _{DIFF} = 60 V, V _{OUT} = 1.4 V (forced)	1,2,3	02	7		
Current limit <u>3</u> /	I _{CL}	V _{DIFF} = 15 V	1,2,3	01	1.50	3.50	A
		V _{DIFF} = 40 V	1		0.18	1.5	
		V _{DIFF} = 5 V	1,2,3	02	0.5	1.65	
		V _{DIFF} = 40 V	1		0.15	0.65	
		V _{DIFF} = 60 V	1		0.02	0.28	
Device type 03.							
Reference voltage	V _{REF}	V _{DIFF} = 3.0 V	1	03	-1.275	-1.225	V
			2,3		-1.30	-1.20	
		V _{DIFF} = 40 V	1		-1.275	-1.225	
			2,3		-1.30	-1.20	
Line regulation	R _{LINE}	3.0 V ≤ V _{DIFF} ≤ 40 V	1	03		±9	mV
			2,3			±23	

See footnotes at end of table.

STANDARD MICROCIRCUIT DRAWING DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE A		5962-99612
		REVISION LEVEL B	SHEET 7

TABLE I. Electrical performance characteristics – Continued.

Test	Symbol	Conditions -55°C ≤ T _A ≤ +125°C I _L = 8 mA unless otherwise specified	Group A subgroups	Device type	Limits		Unit
					Min	Max	
Device type 03 - Continued.							
Load regulation <u>2/</u>	R _{LOAD}	V _{DIFF} = 5 V, 8 mA ≤ I _L ≤ 1.5 A	1,2,3	03		±25	mV
		V _{DIFF} = 12 V, 8 mA ≤ I _L ≤ 1.5 A	1			±25	
		V _{DIFF} = 40V, 8 mA ≤ I _L ≤ 200 mA	1			±25	
		V _{DIFF} = 40 V, 8 mA ≤ I _L ≤ 100 mA	2,3			±25	
Thermal regulation	V _{RTH}	V _{IN} = -14.6 V, I _L = 1.5 A, P _D = 20 watts, t = 10 ms, T _A = +25°C	1	03		±5	mV
Ripple rejection <u>3/</u>	R _N	f = 120 Hz, C _{ADJ} = 10 μF, V _{OUT} = V _{REF}	4,5,6	03	66		dB
Adjustment pin current	I _{ADJ}	V _{DIFF} = 3.0 V	1,2,3	03		100	μA
		V _{DIFF} = 40 V	1,2,3			100	
Adjustment pin current change	ΔI _{ADJ} (line)	3.0 V ≤ V _{DIFF} ≤ 40 V	1,2,3	03		±5	μA
	ΔI _{ADJ} (load)	V _{DIFF} = 5.0 V, 8 mA ≤ I _L ≤ 1.5 A	1,2,3			±5	
Minimum load current	I _{LMIN}	V _{DIFF} = 3.0 V, V _{OUT} = -1.4 V (forced)	1,2,3	03		3	mA
		V _{DIFF} = 10 V, V _{OUT} = -1.4 V (forced)	1,2,3			3	
		V _{DIFF} = 40 V, V _{OUT} = -1.4 V (forced)	1,2,3			5	
Current limit <u>3/</u>	I _{CL}	V _{DIFF} = 5 V	1,2,3	03	1.5	3.5	A
		V _{DIFF} = 40 V	1		0.24	1.2	

Device type 04.

Reference voltage	V _{REF}	V _{DIFF} = 3.0 V	1	04	-1.275	-1.225	V
			2,3		-1.300	-1.200	
		V _{DIFF} = 50 V	1		-1.275	-1.225	
			2,3		-1.300	-1.200	
Line regulation	R _{LINE}	3.0 V ≤ V _{DIFF} ≤ 50 V	1	04		±10	mV
			2,3			±25	

See footnotes at end of table.

STANDARD MICROCIRCUIT DRAWING DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE A		5962-99612
		REVISION LEVEL B	SHEET 8

TABLE I. Electrical performance characteristics – Continued.

Test	Symbol	Conditions -55°C ≤ T _A ≤ +125°C I _L = 8 mA unless otherwise specified	Group A subgroups	Device type	Limits		Unit
					Min	Max	
Device type 04 - Continued.							
Load regulation <u>2/</u>	R _{LOAD}	V _{DIFF} = 50 V, 8 mA ≤ I _L ≤ 110 mA	1	04		±25	mV
		V _{DIFF} = 5.0 V, 8 mA ≤ I _L ≤ 1.5 A	1			±25	
			2,3			±45	
Thermal regulation	V _{RTH}	V _{IN} = -14.6 V, I _L = 1.5 A, P _D = 20 watts, t = 10 ms, T _A = +25°C	1	04		±5	mV
Ripple rejection <u>3/</u>	R _N	f = 120 Hz, C _{ADJ} = 10 μF, V _{OUT} = V _{REF}	4,5,6	04	66		dB
Adjustment pin current	I _{ADJ-1}	V _{DIFF} = 3.0 V	1,2,3	04		100	μA
	I _{ADJ-2}	V _{DIFF} = 40 V	1,2,3			100	
	I _{ADJ-3}	V _{DIFF} = 50 V	1,2,3			100	
Adjustment pin current change	ΔI _{ADJ}	V _{DIFF} = 5.0 V, 8 mA ≤ I _{OUT} ≤ 1.5 A	1,2,3	04		±5	μA
		I _L = 8 mA, 3.0 V ≤ V _{DIFF} ≤ 50 V	1,2,3			±6	
Minimum load current	I _{LMIN}	V _{DIFF} = 3.0 V, V _{OUT} = -1.4 V (forced)	1,2,3	04		3	mA
		V _{DIFF} = 10 V, V _{OUT} = -1.4 V (forced)	1,2,3			3	
		V _{DIFF} = 40 V, V _{OUT} = -1.4 V (forced)	1,2,3			5	
		V _{DIFF} = 50 V, V _{OUT} = -1.4 V (forced)	1,2,3			5	
Current limit <u>3/</u>	I _{CL}	V _{DIFF} = 5 V	1,2,3	04	1.5	3.5	A
		V _{DIFF} = 50 V	1		0.2	1.0	

1/ To determine the line regulation limits for 3.0 V < V_{DIFF} < 60 V (or 3.3 V ≤ V_{DIFF} ≤ 60 V) add the limits for 3.0 V < V_{DIFF} < 40 V (or 3.3 V ≤ V_{DIFF} ≤ 40 V) to the limits for 40 V < V_{DIFF} < 60 V.

2/ Regulation is measured at a constant junction temperature, using pulse testing with a low duty cycle. Changes in output voltage due to heating effects are covered under the specification for thermal regulation. With exception of cases U and Z, all output measurements are referenced to the case. Measurements taken at the output lead must be adjusted for lead resistance.

3/ If not tested, shall be guaranteed to the specified limits.

**STANDARD
MICROCIRCUIT DRAWING**
DLA LAND AND MARITIME
COLUMBUS, OHIO 43218-3990

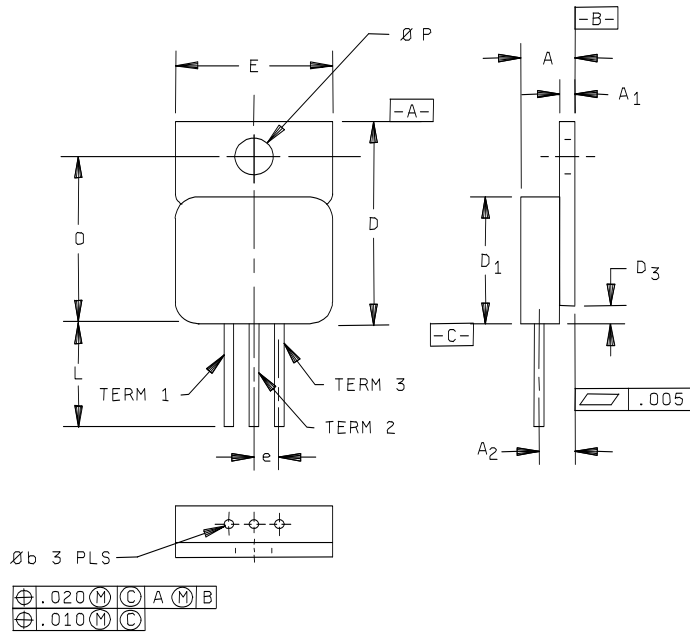
SIZE
A

5962-99612

REVISION LEVEL
B

SHEET
9

Case outlines T and U.



Inches	mm
0.005	0.13
0.010	0.25
0.020	0.51

Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	4.83	5.08	0.190	0.200
A1	0.89	1.14	0.035	0.045
A2	3.05 BSC		0.120 BSC	
øb	0.64	0.89	0.025	0.035
D	16.38	16.89	0.645	0.665
D1	10.41	10.92	0.410	0.430
D3	0.00	1.65	0.000	0.065
e	2.54 BSC		0.100 BSC	
E	10.41	10.72	0.410	0.422
L	12.70	19.05	0.500	0.750
O	13.39	13.64	0.527	0.537
øP	3.56	3.81	0.140	0.150

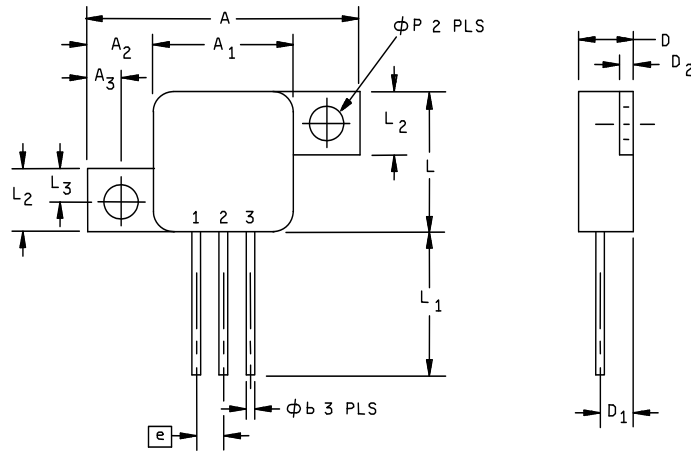
NOTE:

The U.S. government preferred system of measurement is the metric SI system. However, this item was originally designed using inch-pound units of measurement. In the event of conflict between the metric and inch-pound units, the inch-pound units shall take precedence.

FIGURE 1. Case outline(s).

STANDARD MICROCIRCUIT DRAWING DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE A		5962-99612
		REVISION LEVEL B	SHEET 10

Case outlines N and Z.



Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	23.11	23.37	0.910	0.920
A1	10.41	10.67	0.410	0.420
A2	6.22	6.48	0.245	0.255
A3	3.05	3.30	0.120	0.130
ϕb	0.71	0.81	0.028	0.032
D	4.70	5.59	0.135	0.220
D1	2.92	3.18	0.115	0.125
D2	0.89	1.14	0.035	0.045
e	2.54 BSC		0.100 BSC	
L	10.41	10.67	0.410	0.420
L1	12.70	19.05	0.500	0.750
L2	6.22	6.48	0.245	0.255
L3	3.05	3.30	0.120	0.130
ϕP	3.05	3.30	0.120	0.130

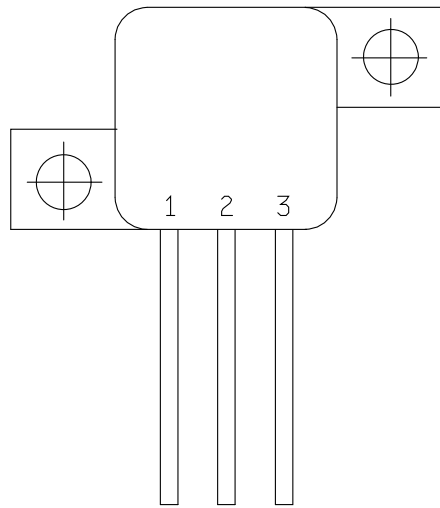
NOTE:

The U.S. government preferred system of measurement is the metric SI system. However, this item was originally designed using inch-pound units of measurement. In the event of conflict between the metric and inch-pound units, the inch-pound units shall take precedence.

FIGURE 1. Case outline(s) - Continued.

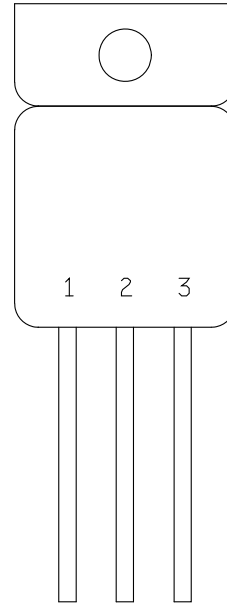
STANDARD MICROCIRCUIT DRAWING DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE A		5962-99612
		REVISION LEVEL B	SHEET 11

Case outlines N and Z



Top view

Case outlines T and U



Top view

Device type	01, 02	03, 04	01, 02	03, 04
Case outlines	N and T (non-isolated tab)	N and T (non-isolated tab)	U and Z (isolated tab)	U and Z (isolated tab)
Terminal number	Terminal symbol	Terminal symbol	Terminal symbol	Terminal symbol
1 2 3 Tab	ADJUST No connection Input Output	ADJUST No connection Output Input	ADJUST Output Input No connection	ADJUST Input Output No connection

FIGURE 2. Terminal connections.

**STANDARD
MICROCIRCUIT DRAWING**
DLA LAND AND MARITIME
COLUMBUS, OHIO 43218-3990

SIZE
A

5962-99612

REVISION LEVEL
B

SHEET
12

TABLE II. Electrical test requirements.

MIL-PRF-38534 test requirements	Subgroups (in accordance with MIL-PRF-38534, group A test table)
Interim electrical parameters	1
Final electrical parameters	1*, 2, 3, 4**, 5**, 6**
Group A test requirements	1, 2, 3
Group C end-point electrical <u>1/</u> parameters	1,2,3
End-point electrical parameters for Radiation Hardness Assurance (RHA) devices	Not applicable

- 1/ As a minimum, for all Group C testing performed after (11-05-20) manufacturers shall perform subgroups 1, 2, and 3 from the Group A electrical test table (Table C-Xa of MIL-PRF-38534).
- * PDA applies to subgroup 1.
- ** Subgroups 4, 5, and 6, if not tested shall be guaranteed to the limits specified in table I.

4.3.5 Radiation Hardness Assurance (RHA) inspection. RHA inspection is not currently applicable to this drawing.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-PRF-38534.

6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use for Government microcircuit applications (original equipment), design applications, and logistics purposes.

6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

6.3 Configuration control of SMD's. All proposed changes to existing SMD's will be coordinated as specified in MIL-PRF-38534.

6.4 Record of users. Military and industrial users shall inform DLA Land and Maritime when a system application requires configuration control and the applicable SMD. DLA Land and Maritime will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronic devices (FSC 5962) should contact DLA Land and Maritime - VA, telephone (614) 692-0544.

6.5 Comments. Comments on this drawing should be directed to DLA Land and Maritime -VA, Columbus, Ohio 43218-3990, or telephone (614) 692-1081.

6.6 Sources of supply. Sources of supply are listed in MIL-HDBK-103 and QML-38534. The vendors listed in MIL-HDBK-103 and QML-38534 have submitted a certificate of compliance (see 3.7 herein) to DLA Land and Maritime - VA and have agreed to this drawing.

STANDARD MICROCIRCUIT DRAWING DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE A		5962-99612
		REVISION LEVEL B	SHEET 13

STANDARD MICROCIRCUIT DRAWING BULLETIN

DATE: 11-05-20

Approved sources of supply for SMD 5962-99612 are listed below for immediate acquisition information only and shall be added to MIL-HDBK-103 and QML-38534 during the next revisions. MIL-HDBK-103 and QML-38534 will be revised to include the addition or deletion of sources. The vendors listed below have agreed to this drawing and a certificate of compliance has been submitted to and accepted by DLA Land and Maritime - VA. This information bulletin is superseded by the next dated revision of MIL-HDBK-103 and QML-38534. DLA Land and Maritime maintains an online database of all current sources of supply at <http://www.dsccl.dla.mil/Programs/Smcr/>

Standard microcircuit drawing PIN <u>1/</u> <u>2/</u>	Vendor CAGE number	Vendor similar PIN <u>3/</u>
5962-9961201HNA	21845	SDP117NHD
5962-9961201HNC	21845	SDP117NHG
5962-9961201HTA	21845	SDP117THD
5962-9961201HTC	21845	SDP117THG
5962-9961201HUA	21845	SDP117UHD
5962-9961201HUC	21845	SDP117UHG
5962-9961201HZA	21845	SDP117ZHD
5962-9961201HZC	21845	SDP117ZHG
5962-9961202HNA	21845	SDP117HVNHHD
5962-9961202HNC	21845	SDP117HVNHG
5962-9961202HTA	21845	SDP117HVTHD
5962-9961202HTC	21845	SDP117HVTHG
5962-9961202HUA	21845	SDP117HVUHD
5962-9961202HUC	21845	SDP117HVUHG
5962-9961202HZA	21845	SDP117HVZHD
5962-9961202HZC	21845	SDP117HVZHG
5962-9961203HNA	21845	SDP137NHD
5962-9961203HNC	21845	SDP137NHG
5962-9961203HTA	21845	SDP137THD
5962-9961203HTC	21845	SDP137THG
5962-9961203HUA	21845	SDP137UHD
5962-9961203HUC	21845	SDP137UHG
5962-9961203HZA	21845	SDP137ZHD
5962-9961203HZC	21845	SDP137ZHG
5962-9961204HNA	21845	SDP137HVNHHD
5962-9961204HNC	21845	SDP137HVNHG
5962-9961204HTA	21845	SDP137HVTHD
5962-9961204HTC	21845	SDP137HVTHG
5962-9961204HUA	21845	SDP137HVUHD
5962-9961204HUC	21845	SDP137HVUHG
5962-9961204HZA	21845	SDP137HVZHD
5962-9961204HZC	21845	SDP137HVZHG

- 1/ The lead finish shown for each PIN, representing a hermetic package, is the most readily available from the manufacturer listed for that part. If the desired lead finish is not listed contact the Vendor to determine availability.
- 2/ The SMD device types listed above are similar to the device types listed on SMD 77034. 5962-9961201HTA through 04HTA are similar to 7703401TA through 04TA. 5962-9961201HUA through 04HUA are similar to 7703401UA through 04UA.
- 3/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE
number

21845

Vendor name
and address

Soliton Devices, Incorporated
3301 Electronics Way
West Palm Beach, FL 33407-4697

The information contained herein is disseminated for convenience only and the Government assumes no liability whatsoever for any inaccuracies in the information bulletin.